



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	BV _{DSS}	Rds(on) max	I _{D MAX} T _A = +25°C
		$34m\Omega$ @ $V_{GS} = 4.5V$	5.1A
Q1	12V	$40 \text{m}\Omega$ @ $V_{GS} = 2.5 \text{V}$	4.7A
N-Channel		$50m\Omega$ @ $V_{GS} = 1.8V$	4.2A
		$70m\Omega$ @ $V_{GS} = 1.5V$	3.6A
		$59m\Omega$ @ $V_{GS} = -4.5V$	-3.9A
Q2 P-Channel	-12	$81m\Omega @ V_{GS} = -2.5V$	-3.3A
		115mΩ @ V _{GS} = -1.8V	-2.8A
		$215 \text{m}\Omega$ @ $V_{GS} = -1.5V$	-2.0A

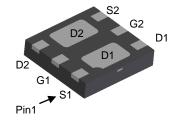
Description and Applications

This MOSFET is designed to meet the stringent requirements of Automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

- Load Switch
- **Power Management Functions**
- Portable Power Adaptors

U-DFN2020-6 (Type B)





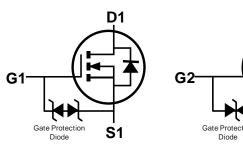
Bottom View

Features

- Low On-Resistance
- Low Input Capacitance
- Low Profile, 0.6mm Max Height
- **ESD Protected Gate**
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

Mechanical Data

- Case: U-DFN2020-6 (Type B)
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @4)
- Terminals Connections: See Diagram Below
- Weight: 0.0065 grams (Approximate)



N-CHANNEL MOSFET

P-CHANNEL MOSFET

D2

S₂

Internal Schematic

Ordering Information (Note 5)

Part Number	Case	Packaging
DMC1030UFDBQ-7	U-DFN2020-6 (Type B)	3000/Tape & Reel
DMC1030UFDBQ-13	U-DFN2020-6 (Type B)	10000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + CI) and
 http://www.diodes.com/product_compliance_definitions.html.

 http://www.diodes.com/product_compliance_definitions.html.
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



D3 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: D = 2016)M = Month (ex: 9 = September)

Date Code Key

Year	201	5	2016		2017	20	18	2019		2020	2	2021
Code	С		D		Е	F	F	G		Н		
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Q1 N-CHANNEL	Q2 P-CHANNEL	Unit		
Drain-Source Voltage			V _{DSS}	12	-12	V
Gate-Source Voltage			V_{GSS}	±8	±8	V
Continuous Drain Current (Note 6) N-CHANNEL: V _{GS} = 4.5V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	5.1 4.1	-3.9 -3.1	А
P-CHANNEL: V _{GS} = -4.5V	t < 5s	$T_A = +25$ °C $T_A = +70$ °C	I _D	6.6 5.3	-5.0 -4.0	А
Maximum Continuous Body Diode Forward Curre		I _S	2	-1.7	Α	
Pulsed Drain Current (10µs Pulse, Duty Cycle =	I _{DM}	35	-25	А		
Avalanche Current (L = 0.1mH)	I _{AS}	5	-5	А		
Avalanche Energy (L = 0.1mH)		•	E _{AS}	4	4	mJ

Thermal Characteristics

Characteristic		Symbol	Value	Unit	
Total Power Dissipation (Note 6)	Steady State	D-	1.36	W	
Total Fower Dissipation (Note o)	t < 5s	P_D	1.89		
Thermal Resistance, Junction to Ambient (Note 6)	Steady State		92		
Thermal Resistance, Junction to Ambient (Note 6)	t < 5s	$R_{\theta JA}$	66	°C/W	
Thermal Resistance, Junction to Case (Note 6)	$R_{\theta JC}$	18			
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C	

Electrical Characteristics Q1 N-CHANNEL (@ T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 7)								
Drain-Source Breakdown Voltage	BV _{DSS}	12	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$		
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	1.0	μA	V _{DS} = 12V, V _{GS} = 0V		
Gate-Source Leakage	I _{GSS}	_	_	±10	μA	$V_{GS} = \pm 8V$, $V_{DS} = 0V$		
ON CHARACTERISTICS (Note 7)								
Gate Threshold Voltage	V _{GS(TH)}	0.4	_	1	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		
		_	17	34		$V_{GS} = 4.5V, I_D = 4.6A$		
Static Drain-Source On-Resistance	D	_	20	40	mΩ	$V_{GS} = 2.5V, I_D = 4.2A$		
Static Brain-Source On-Nesistance	R _{DS(ON)}	_	24	50	11152	$V_{GS} = 1.8V, I_D = 3.8A$		
		_	28	70		$V_{GS} = 1.5V, I_D = 1.5A$		
Diode Forward Voltage	V _{SD}	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 4.8A$		
DYNAMIC CHARACTERISTICS (Note 8)								
Input Capacitance	C _{iss}	_	1003	_	pF	\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		
Output Capacitance	Coss	_	132	_	pF	$V_{DS} = 6V, V_{GS} = 0V,$ -f = 1.0MHz		
Reverse Transfer Capacitance	C _{rss}	_	115	_	pF	7 - 1.00012		
Gate Resistance	Rg	_	11.3	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$		
Total Gate Charge (V _{GS} = 4.5V)	0	_	12.2	_	nC			
Total Gate Charge (V _{GS} = 8V)	Qg	_	23.1	_	nC	V _{DS} = 10V. I _D = 6.8A		
Gate-Source Charge	Q _{gs}	_	1.3	_	nC	V _{DS} = 10V, I _D = 6.6A		
Gate-Drain Charge	Q_{gd}	_	1.5	_	nC			
Turn-On Delay Time	t _{D(ON)}	_	4.4	_	ns			
Turn-On Rise Time	t _R	_	7.4	_	ns	$V_{DD} = 6V, V_{GS} = 4.5V,$		
Turn-Off Delay Time	t _{D(OFF)}	_	18.8	_	ns	$R_L = 1.1\Omega$, $R_G = 1\Omega$		
Turn-Off Fall Time	t _F	_	4.9	_	ns			
Body Diode Reverse Recovery Time	t _{RR}	_	7.6	_	ns	$I_S = 5.4A$, $dI/dt = 100A/\mu s$		
Body Diode Reverse Recovery Charge	Q_{RR}	_	0.9	_	nC	$I_S = 5.4A$, $dI/dt = 100A/\mu s$		

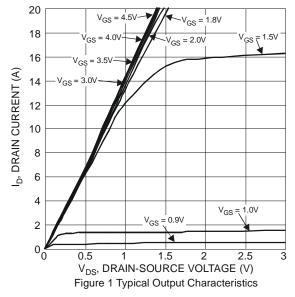
Notes: 6. Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. Copper, single sided.

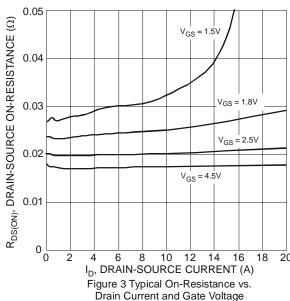
^{7.} Short duration pulse test used to minimize self-heating effect.

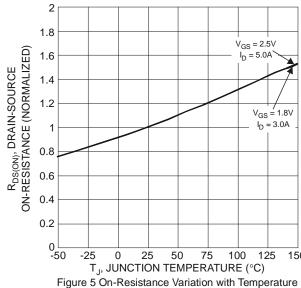
^{8.} Guaranteed by design. Not subject to product testing.

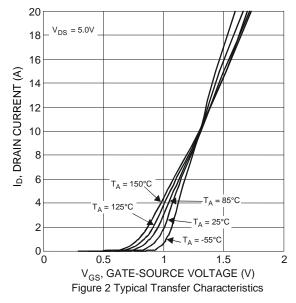


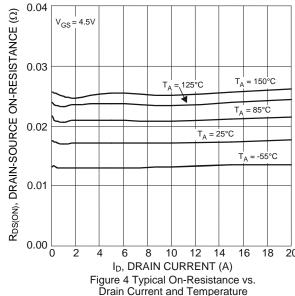












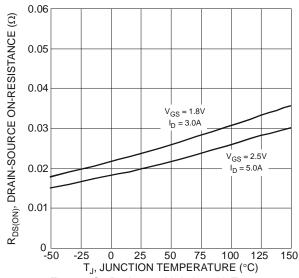


Figure 6 On-Resistance Variation with Temperature



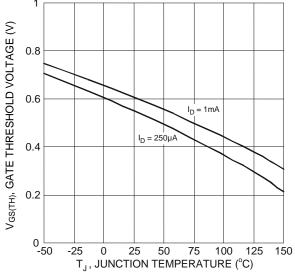
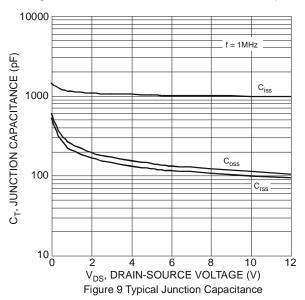
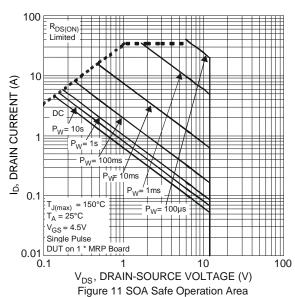
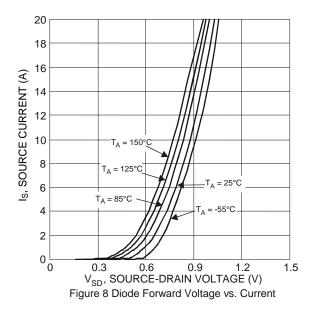
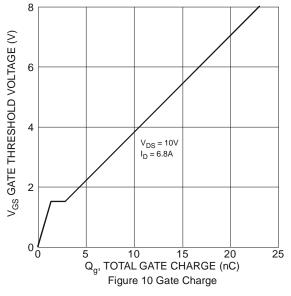


Figure 7 Gate Threshold Variation vs. Junction Temperature









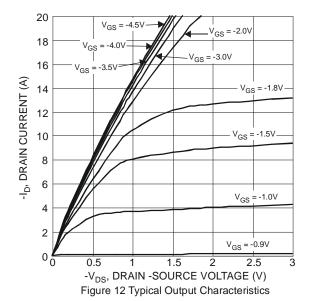


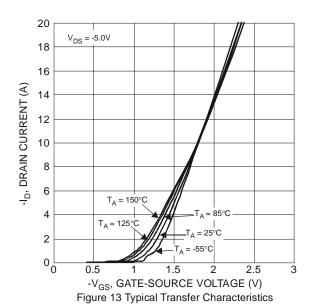
Electrical Characteristics Q2 P-CHANNEL (@ T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition			
OFF CHARACTERISTICS (Note 7)									
Drain-Source Breakdown Voltage	BV _{DSS}	-12	-	_	V	$V_{GS} = 0V, I_D = -250\mu A$			
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}		_	-1.0	μA	$V_{DS} = -12V, V_{GS} = 0V$			
Gate-Source Leakage	I_{GSS}		_	±10	μA	$V_{GS} = \pm 8V$, $V_{DS} = 0V$			
ON CHARACTERISTICS (Note 7)	ON CHARACTERISTICS (Note 7)								
Gate Threshold Voltage	V _{GS(TH)}	-0.4	1	-1	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$			
			37	59		$V_{GS} = -4.5V$, $I_D = -3.6A$			
Static Drain-Source On-Resistance	D-s/s/		48	81	mΩ	$V_{GS} = -2.5V$, $I_D = -3.1A$			
Glatic Dialif-Gource Off-Nesistance	R _{DS(ON)}		69	115	11122	$V_{GS} = -1.8V, I_D = -2.6A$			
		-	88	215		$V_{GS} = -1.5V, I_D = -0.5A$			
Diode Forward Voltage	V _{SD}	_	-0.7	-1.2	V	V _{GS} = 0V, I _S = -3.7A			
DYNAMIC CHARACTERISTICS (Note 8)									
Input Capacitance	C _{iss}		1028	_	pF	V 0V V 0V			
Output Capacitance	Coss		285	_	pF	$V_{DS} = -6V, V_{GS} = 0V,$ -f = 1.0MHz			
Reverse Transfer Capacitance	C _{rss}	-	254	_	pF	1 - 1.000112			
Gate Resistance	R_g	-	19.6	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$			
Total Gate Charge (V _{GS} = -4.5V)	0		13	_	nC				
Total Gate Charge (V _{GS} = -8V)	Qg		20.8	_	nC	101/ 1 174			
Gate-Source Charge	Q _{gs}	_	1.8	_	nC	$V_{DS} = -10V, I_{D} = -4.7A$			
Gate-Drain Charge	Q_{gd}	_	4.5	_	nC				
Turn-On Delay Time	t _{D(ON)}	_	5.6	_	ns				
Turn-On Rise Time	t _R		12.8	_	ns	$V_{DD} = -6V, V_{GS} = -4.5V,$			
Turn-Off Delay Time	t _{D(OFF)}	_	30.7	_	ns	$R_L = 1.6\Omega$, $R_G = 1\Omega$			
Turn-Off Fall Time	t _F	_	25.4	_	ns				
Body Diode Reverse Recovery Time	t _{RR}	_	31.6	_	ns	$I_S = -3.6A$, $dI/dt = 100A/\mu s$			
Body Diode Reverse Recovery Charge	Q_{RR}	_	7.8	_	nC	$I_S = -3.6A$, $dI/dt = 100A/\mu s$			

Notes:

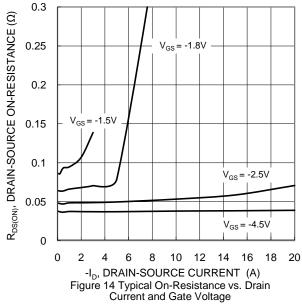
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.

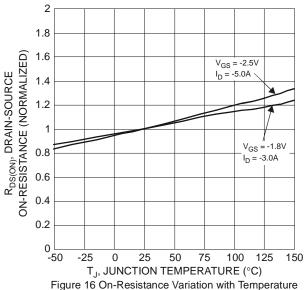












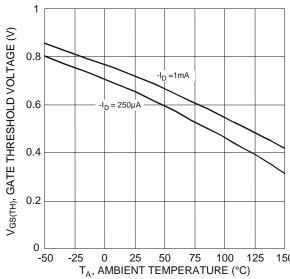
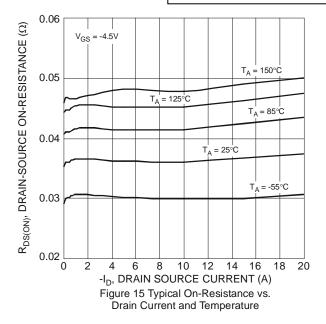
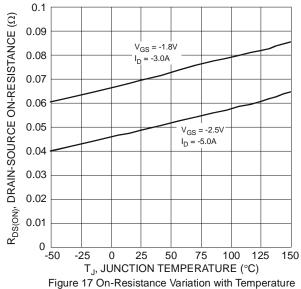


Figure 18 Gate Threshold Variation vs. Ambient Temperature

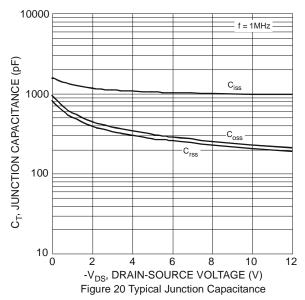


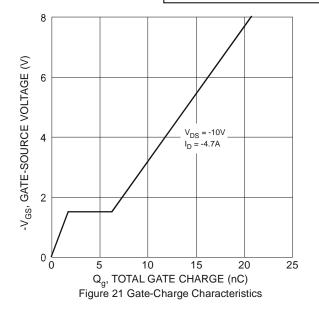


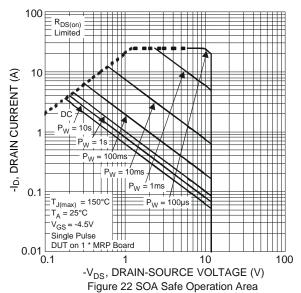
20 18 16 -Is, SOURCE CURRENT (A) 14 12 10 T_A = 150°C 8 6 2 0 0 0.6 0.9 1.2 1.5 -V_{SD}, SOURCE-DRAIN VOLTAGE (V) Figure 19 Diode Forward Voltage vs. Current

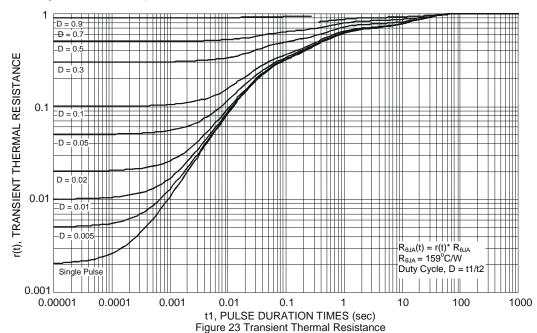










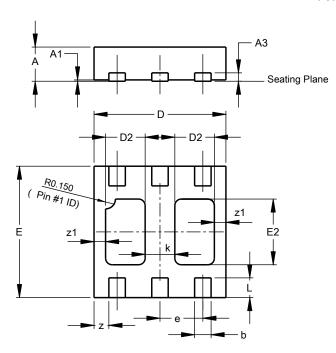




Package Outline Dimensions

Please see AP02001 at http://www.diodes.com/_files/datasheets/ap02001.pdf for the latest version.

U-DFN2020-6 (Type B)

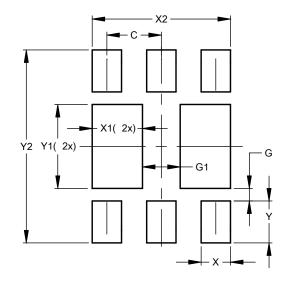


U-DFN2020-6									
	Type B								
Dim	Min	Max	Тур						
Α	0.545	0.605	0.575						
A1	0.00	0.05	0.02						
A3	-	-	0.13						
b	0.20	0.30	0.25						
D	1.95	2.075	2.00						
D2	0.50	0.70	0.60						
е	-	-	0.65						
Е	1.95	2.075	2.00						
E2	0.90	1.10	1.00						
k	-	-	0.45						
٦	0.25	0.35	0.30						
Z	-	-	0.225						
z1	-	-	0.175						
All	Dimens	All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/_files/datasheets/ap02001.pdf for the latest version.

U-DFN2020-6 (Type B)



Dimensions	Value		
Dillicitations	(in mm)		
С	0.650		
G	0.150		
G1	0.450		
Х	0.350		
X1	0.600		
X2	1.650		
Y	0.500		
Y1	1.000		
Y2	2.300		



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